

Report No.: EED32Q82021202 Page 1 of 8

# **RF Exposure Evaluation Report**

Product : Omi

Trade mark : Seeed Studio

**Model/Type reference** : Omi **Serial Number** : N/A

Report Number : EED32Q82021202

FCC ID : Z4T-OMI

**Date of Issue** : Feb. 26, 2025

Test Standards : 47 CFR Part 1.1307

47 CFR Part 1.1310 47 CFR Part 2.1091 47 CFR Part 2.1093

KDB 447498 D04 Interim General RF

Exposure Guidance v01

Test result : PASS

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Prepared for:

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Reviewed by:

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Date:

Check No.: 3457051224

Feb. 26, 2025









Page 2 of 8

Report No. : EED32Q82021202

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Report No.: EED32Q82021202

Page 3 of 8

# **Contents**

							Page
1 VERSION	l	•••••	•••••	•••••	•••••	•••••	2
	TS						
	L INFORMATION.						
3.2 GENEI 3.3 PRODU 3.4 TEST I 3.5 DEVIA 3.6 ABNO	IT INFORMATION  RAL DESCRIPTION OF  UCT SPECIFICATION S  LOCATION  ATION FROM STANDAL  RMALITIES FROM STA  R INFORMATION REQ	EUT  UBJECTIVE TO   RDS  ANDARD CONDI	THIS STANDARE	)			
	LUATION						
4.1.1 L 4.1.2	KPOSURE COMPLIANC Limits Test Procedure EUT RF Exposure I						<i>6</i>



Report No.: EED32Q82021202 Page 4 of 8

# 3 General Information

# 3.1 Client Information

Applicant:	Seeed Technology Co., Ltd
Address of Applicant:	9F, G3 Building, TCL International E City, Zhongshanyuan Road, Nanshan District, Shenzhen
Manufacturer:	Seeed Technology Co., Ltd
Address of Manufacturer:	9F, G3 Building, TCL International E City, Zhongshanyuan Road, Nanshan District, Shenzhen
Factory:	Shenzhen Xinxian Technology Co.,Limited
Address of Factory:	F5, Building B17, Hengfeng Industrial City, No. 739 Zhoushi Rd, Baoan District, Shenzhen, Guangdong, P.R.C.

# 3.2 General Description of EUT

Product Name:	Omi	_°>	(*)	
Model No.(EUT):	Omi	(65)		(25)
Trade Mark:	Seeed Studio			

## 3.3 Product Specification subjective to this standard

Frequency Range:	2402MHz~2480MHz					
Modulation Type:	GFSK, π/4DQPSK	(0,)				
Test Power Grade:	Default					
Test Software of EUT:	sscom5.13.1.exe					
Antenna Type:	Ceramic Antenna					
Antenna Gain:	4.97dBi	(25)				
Power Supply:	Battery: DC 3.7V					
Sample Received Date:	Dec. 18, 2024					
Sample tested Date:	Dec. 18, 2024 to Dec. 29, 2024					

### Remark:

Company Name and Address shown on Report, the sample(s) and sample Information was/ were provided by the applicant who should be responsible for the authenticity which CTI hasn't verified.







### 3.4 Test Location

All tests were performed at:

Centre Testing International Group Co., Ltd

Building C, Hongwei Industrial Park Block 70, Bao'an District, Shenzhen, China

Telephone: +86 (0) 755 33683668 Fax:+86 (0) 755 33683385

No tests were sub-contracted. FCC Designation No.: CN1164

# 3.5 Deviation from Standards

None.

## 3.6 Abnormalities from Standard Conditions

# 3.7 Other Information Requested by the Customer







# 4 SAR Evaluation

# 4.1 RF Exposure Compliance Requirement

### **4.1.1 Limits**

The SAR-based exemption formula of § 1.1307(b)(3)(i)(B), repeated here as Formula (B.2), applies for single fixed, mobile, and portable RF sources with available maximum time-averaged power or effective radiated power (ERP), whichever is greater, of less than or equal to the threshold Pth (mW).

This method shall only be used at separation distances from 0.5 cm to 40 cm and at frequencies from 0.3 GHz to 6 GHz (inclusive). Pth is given by Formula

$$P_{\text{th}} \text{ (mW)} = \begin{cases} ERP_{20 \text{ cm}} (d/20 \text{ cm})^x & d \le 20 \text{ cm} \\ ERP_{20 \text{ cm}} & 20 \text{ cm} < d \le 40 \text{ cm} \end{cases}$$

where

$$x = -\log_{10}\left(\frac{60}{ERP_{20\,\mathrm{cm}}\sqrt{f}}\right)$$

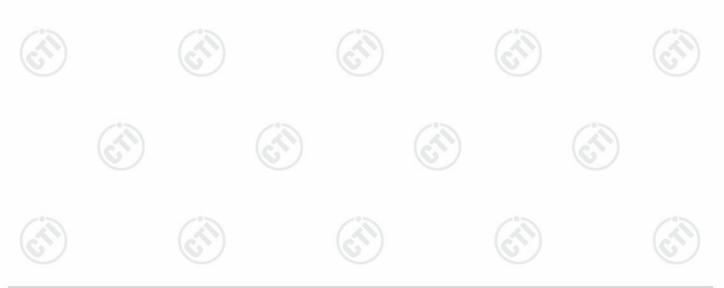
and f is in GHz, d is the separation distance (cm), and ERP20cm is per Formula (B.1).

$$P_{\text{th}} (\text{mW}) = ERP_{20 \text{ cm}} (\text{mW}) = \begin{cases} 2040f & 0.3 \text{ GHz} \le f < 1.5 \text{ GHz} \\ \\ 3060 & 1.5 \text{ GHz} \le f \le 6 \text{ GHz} \end{cases}$$
(B. 1)

The 1 mW Blanket Exemption of § 1.1307(b)(3)(i)(A) applies for single fixed, mobile, and portable RF sources with available maximum time-averaged power of no more than 1 mW, regardless of separation distance.

### 4.1.2 Test Procedure

Software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel individually.





Report No.: EED32Q82021202 Page 7 of 8

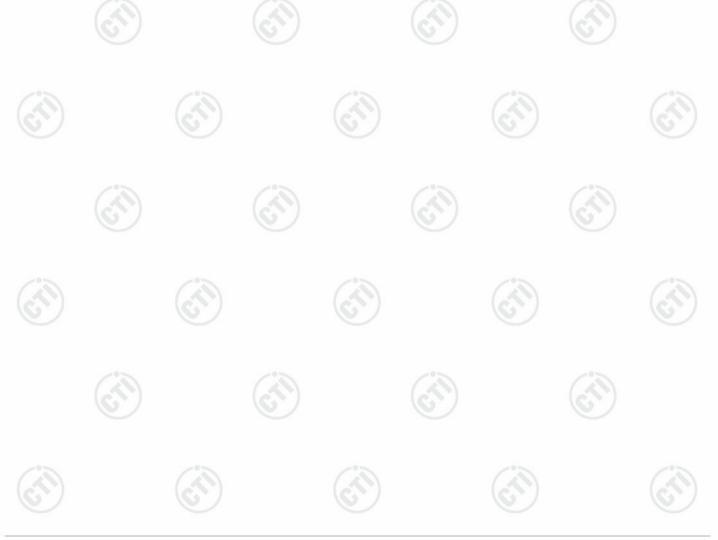
### 4.1.3 EUT RF Exposure Evaluation

### For Stand alone:

100	Frequency (MHz)	Estimation distance (cm)	Max. Conducted Output power (dBm)	Antenna Gain (dBi)	ERP (dBm)	ERP (mW)	Limit (mW)	MPE ratio	Result
	2402	0.5	0.11	4.97	2.93	1.9634	2.7877	0.7043	Pass

### Note:

- ①EIRP=conducted power+antenna gain;
- ②ERP=EIRP-2.15;
- ③EIRP(dBm) = Field strength of the fundamental signal(dBuV/m@3m) 95.23;
- $4ERP(mW) = 10^{(ERP (dBm)/10)};$
- ⑤The estimation distance is 0.5cm;
- **6** The test data please refer to the report of EED32Q82021201 and only the worst case data was recorded in the report.









Report No.: EED32Q82021202 Page 8 of 8

#### Statement

- 1. This report is considered invalid without approved signature, special seal and the seal on the perforation;
- 2. The Company Name shown on Report and Address, the sample(s) and sample information was/were provided by the applicant who should be responsible for the authenticity which CTI hasn't verified;
- 3. The result(s) shown in this report refer(s) only to the sample(s) tested;
- 4. Unless otherwise stated, the decision rule for conformity reporting is based on Binary Statement for Simple Acceptance Rule stated in ILAC-G8:09/2019/CNAS-GL015:2022;
- 5. Without written approval of CTI, this report can't be reproduced except in full;

